

Product Summary

BV_{DSS}	$R_{DS(ON)}$ Max	I_D $T_A = +25^\circ C$
-20V	78m Ω @ $V_{GS} = -8V$	-3.4A
	100m Ω @ $V_{GS} = -4.5V$	-3.0A

Description

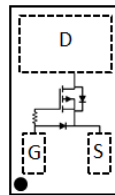
This new generation MOSFET is designed to minimize the footprint in handheld and Mobile application. It can be used to replace many small signals MOSFET with as really small footprint.

Applications

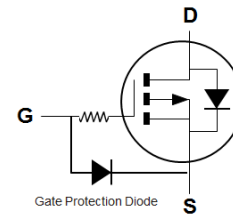
- Battery Management
- Load Switch
- Battery Protection
- Handheld and Mobile Application



X4-DSN1006-3



Top View



Equivalent Circuit

Features and Benefits

- Low Q_g & Q_{gd}
- Small Footprint
- Low Profile 0.20mm Height
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- Halogen and Antimony Free. "Green" Device (Note 3)**

Mechanical Data

- Case: X4-DSN1006-3
- Terminal Connections: See Diagram Below
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish — NiPdAu. Solderable per MIL-STD-202, Method 208 (e4)

Ordering Information (Note 4)

Part Number	Case	Packaging
DMP2078LCA3-7	X4-DSN1006-3	10k/Tape & Reel

- Notes:
- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
 - See <https://www.diodes.com/quality/lead-free/> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
 - Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
 - For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.

Marking Information



O = Product Type Marking Code
 YM = Date Code Marking
 Y or \bar{Y} = Year (ex: F = 2018)
 M or \bar{M} = Month (ex: 9 = September)

Date Code Key

Year	2017	2018	2019	2020	2021	2022	2023	2024	2025
Code	E	F	G	H	I	J	K	L	M

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V _{DSS}	-20	V
Gate-Source Voltage			V _{GSS}	-12	V
Continuous Drain Current (Note 5) V _{GS} = -8V	Steady State	T _A = +25°C	I _D	-3.4	A
		T _A = +70°C		-2.7	
Continuous Drain Current (Note 5) V _{GS} = -4.5V	Steady State	T _A = +25°C	I _D	-3.0	A
		T _A = +70°C		-2.4	
Pulsed Drain Current (Note 6)			I _{DM}	-13	A
Human Body Model (HBM)			V _(ESD)	4	kV

Thermal Characteristics

Characteristic			Symbol	Value	Unit
Power Dissipation (Note 7)			P _D	0.81	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 7)			R _{θJA}	155.4	°C/W
Power Dissipation (Note 5)			P _D	1.4	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)			R _{θJA}	90.4	°C/W
Operating and Storage Temperature Range			T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	-20	—	—	V	V _{GS} = 0V, I _D = -250μA
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	—	—	-100	nA	V _{DS} = -16V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	—	—	-50	nA	V _{GS} = -12V, V _{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(TH)}	-0.7	-0.9	-1.2	V	V _{DS} = V _{GS} , I _D = -250μA
Static Drain-Source On-Resistance	R _{DS(ON)}	—	64	78	mΩ	V _{GS} = -8V, I _D = -0.5A
		—	77	100		V _{GS} = -4.5V, I _D = -0.5A
		—	113	165		V _{GS} = -2.5V, I _D = -0.5A
		—	188	600		V _{GS} = -1.8V, I _D = -0.1A
		—	—	—		—
Diode Forward Voltage	V _{SD}	—	-0.7	-1.0	V	V _{GS} = 0V, I _S = -0.5A
Reverse Recovery Charge	Q _{RR}	—	1.3	—	nC	V _{DD} = -10V, I _F = -1A, di/dt = 100A/μs
Reverse Recovery Time	t _{RR}	—	7.7	—	ns	
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	—	152	228	pF	V _{DS} = -10V, V _{GS} = 0V, f = 1MHz
Output Capacitance	C _{oss}	—	78	117		
Reverse Transfer Capacitance	C _{riss}	—	4.3	6.4		
Series Gate Resistance	R _G	—	21	31	Ω	f = 1MHz, V _{GS} = 0V, V _{DS} = 0V
Total Gate Charge	Q _g	—	1.1	1.6	nC	V _{GS} = -4.5V, V _{DS} = -10V, I _D = -0.5A
Gate-Source Charge	Q _{gs}	—	0.2	—		
Gate-Drain Charge	Q _{gd}	—	0.2	—		
Gate Charge at V _{TH}	Q _{g(th)}	—	3.6	—		
Turn-On Delay Time	t _{D(ON)}	—	4.1	6.1	ns	V _{DS} = -10V, V _{GS} = -4.5V, R _G = 2Ω, I _D = -0.5A
Turn-On Rise Time	t _R	—	5.6	—		
Turn-Off Delay Time	t _{D(OFF)}	—	9.5	14.2		
Turn-Off Fall Time	t _F	—	4.6	—		

- Notes:
- Device mounted on FR-4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.
 - Repetitive rating, pulse width limited by junction temperature.
 - Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
 - Short duration pulse test used to minimize self-heating effect.
 - Guaranteed by design. Not subject to production testing.

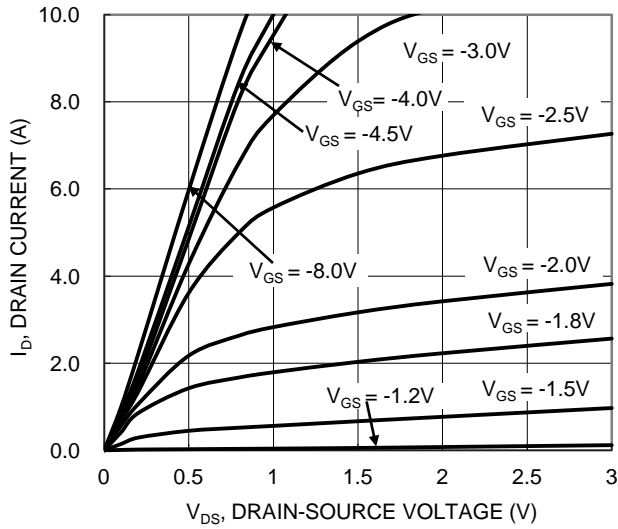


Figure 1. Typical Output Characteristic

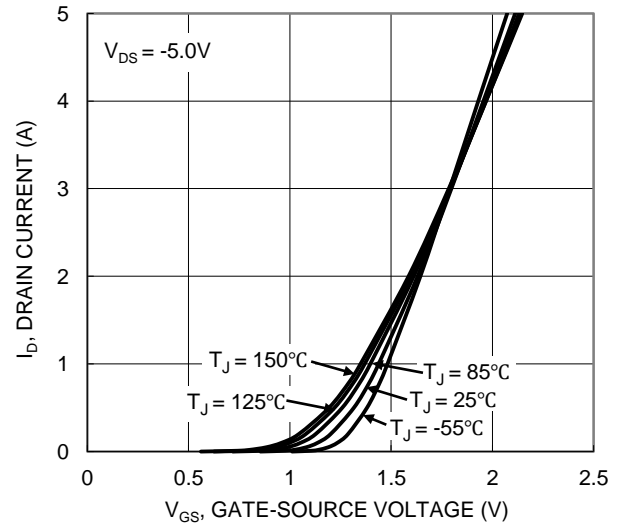


Figure 2. Typical Transfer Characteristic

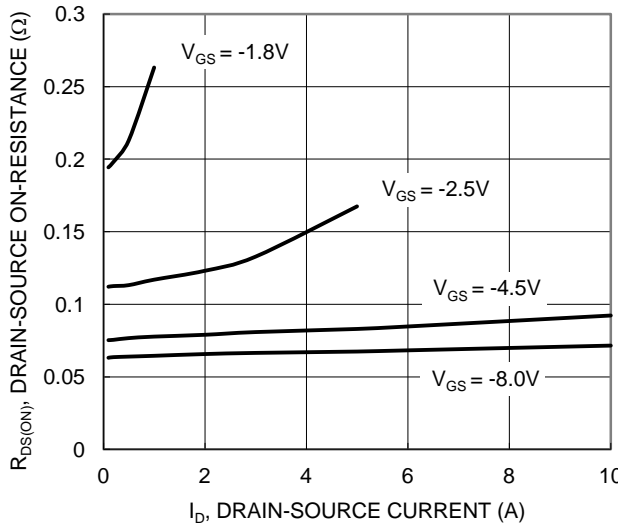


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

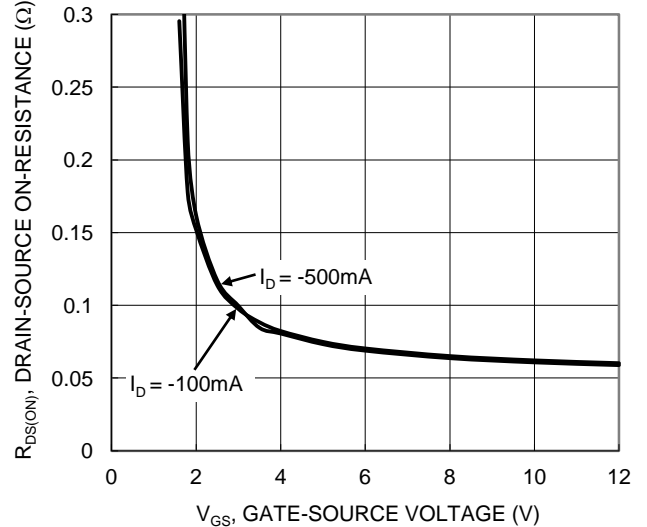


Figure 4. Typical Transfer Characteristic

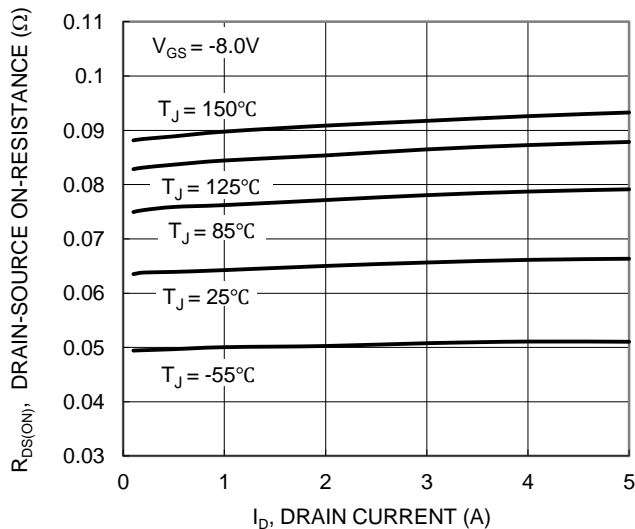


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

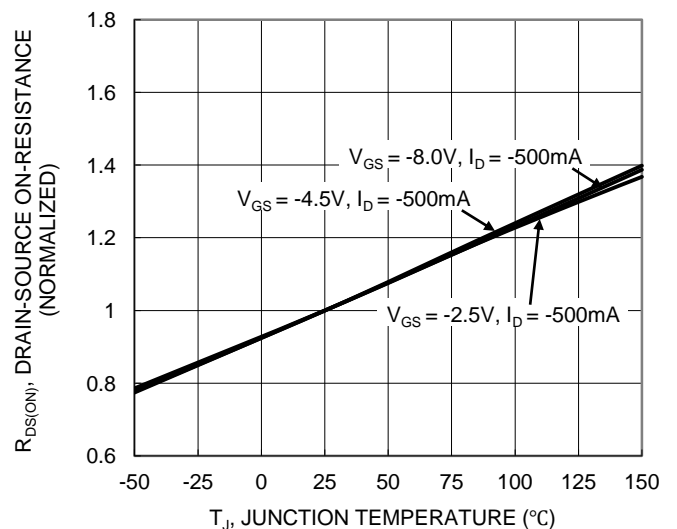
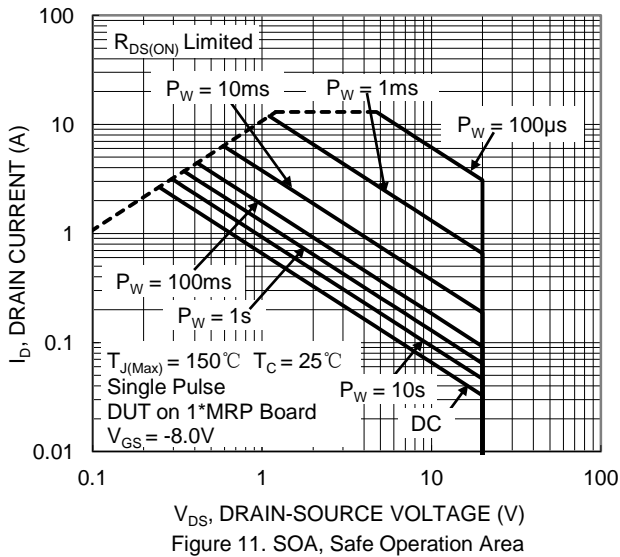
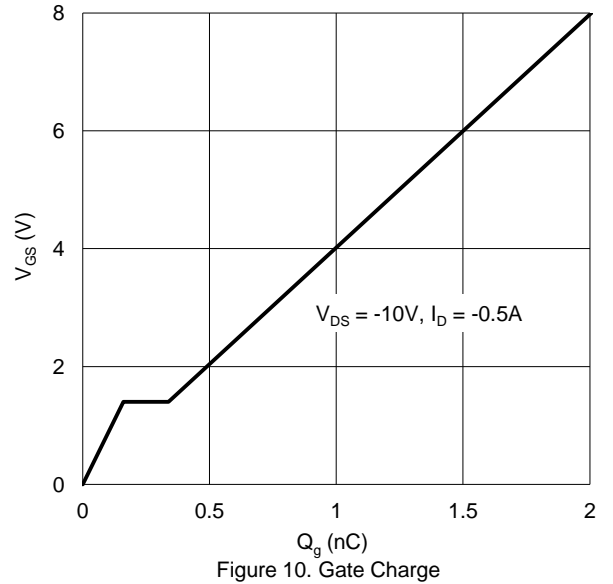
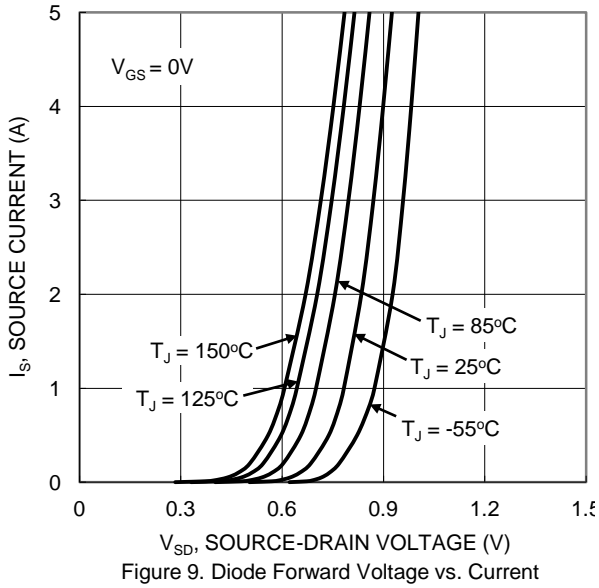
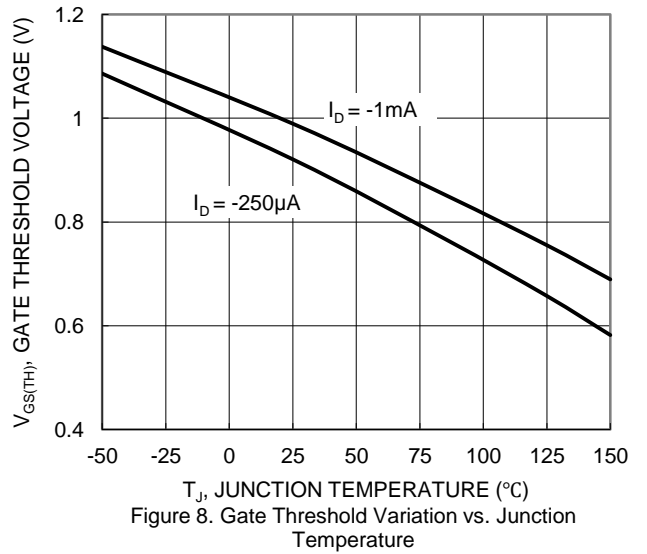
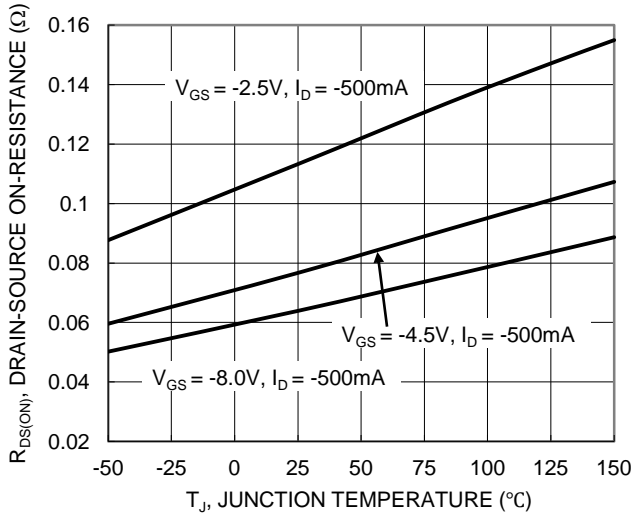


Figure 6. On-Resistance Variation with Junction Temperature



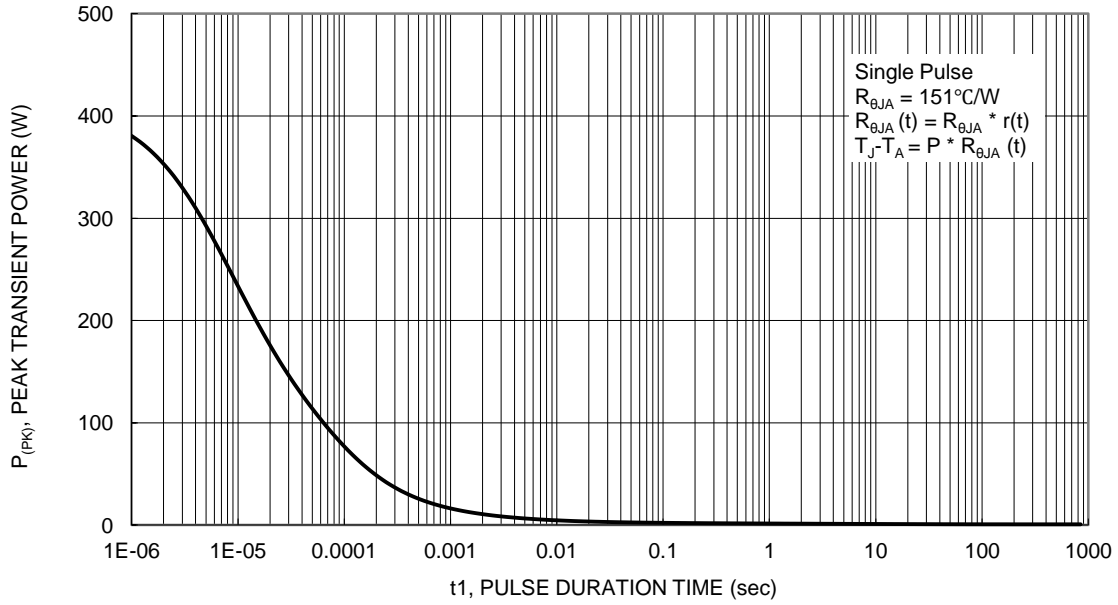


Figure 12. Single Pulse Maximum Power Dissipation

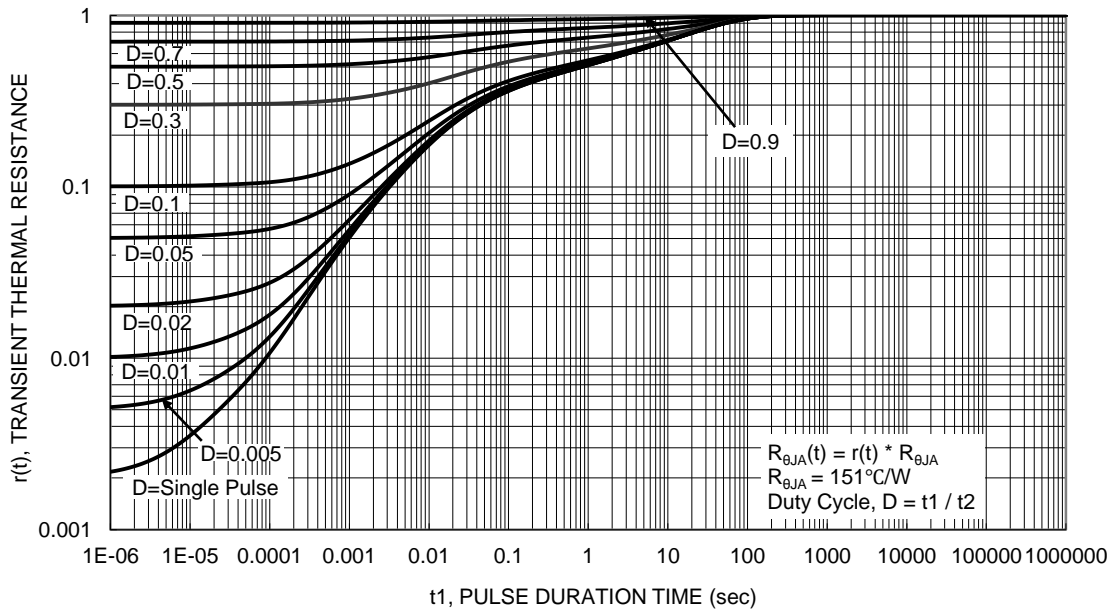
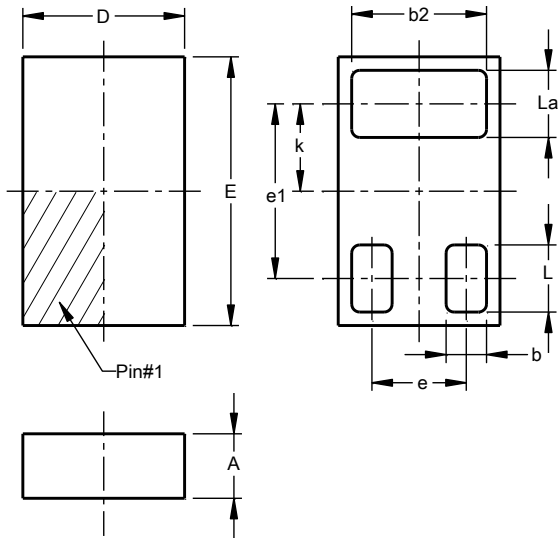


Figure 13. Transient Thermal Resistance

Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

X4-DSN1006-3

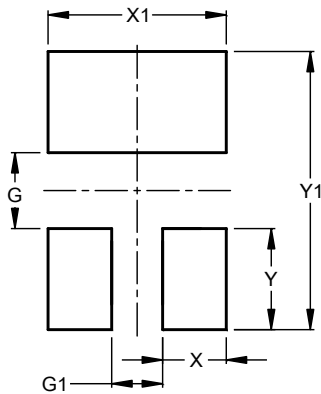


X4-DSN1006-3			
Dim	Min	Max	Typ
A	0.18	0.22	0.20
b	0.14	0.16	0.15
b2	0.49	0.51	0.50
D	0.56	0.64	0.60
E	0.96	1.04	1.00
e	--	--	0.35
e1	--	--	0.65
k	--	--	0.325
L	0.24	0.26	0.25
La	0.24	0.26	0.25
All Dimensions in mm			

Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

X4-DSN1006-3



Dimensions	Value (in mm)
G	0.40
G1	0.20
X	0.15
X1	0.50
Y	0.25
Y1	0.90

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